

Search Notes

Application/Control No.

10/656,409

Examiner

Randall Chin

Applicant(s)/Patent under
Reexamination

D'AGUANNO, FRANCIS D.

Art Unit

1744

SEARCHED

Class	Subclass	Date	Examiner
15	185		
15	236.01		
15	236.05		
15	236.06		
15	236.07		
15	236.08		
15	236.09		
30	153		
30	255		
7	128		
81	177.6		
81	177.7		
81	427.5	9/18/2006	RC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT		
Inventor name search		
Hwei-Siu Payer, Cl..30 search		
Debra Meislin, Cl. 7 and 81 search	9/18/2006	RC